

SAMXON BRAND ALUMINUM ELECTROLYTIC CAPACITORS **PRODUCT SPECIFICATION**

規格書

CUSTOMER :

(客戶):

DATE :

(日期):2019-5-24

CATEGORY (品名)	:	ALUMINUM ELECTROLYTIC CAPACITORS
DESCRIPTION (型号)	:	GF 35V100μF(φ6.3x11)
VERSION (版本)	:	01
Customer P/N	:	
SUPPLIER	:	

SUPPL	IER	CUSTOMER			
PREPARED (拟定)	CHECKED (审核)	APPROVAL (批准)	SIGNATURE (签名)		
赵安平	刘渭清				

ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES

SPECIFICATION				ALTERN	ATION HIS	STORY		
Rev.	Date	GF SEF Mark	RIES Pag	-	Contents	Purpose	Drafter	Approver
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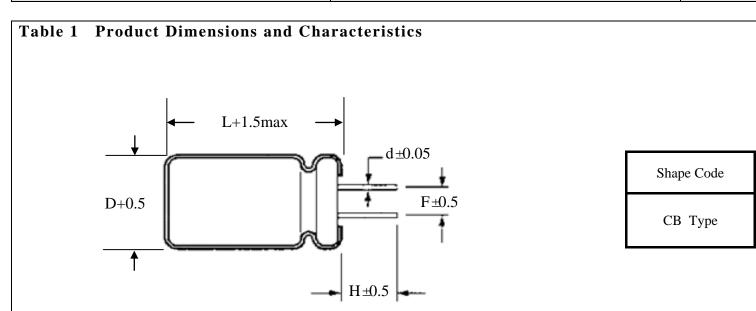


Table 1

No.	SAMXON Part No.	WV (Vdc)	Cap. (µF)	Cap. tolerance	Temp. range(℃)	tan δ (120Hz, 20℃)	Leakage Current (µA,2min)	Max Ripple Current at 105°C 100kHz (mA rms)	Impedance at 20°C 100kHz (Ωmax)
1	EGF107M1VE11CB**P	35	100	-20%~+20%	-40~105	0.12	35	340	0.220

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	Type (2.3) Sleeve Material (2.7) Case Length (2.6) Diameter (2.5)
	Voltage (2.2) Voltage (2.2) Tolerance (2.4) Capacitance (2.1) E-CAP
.1	Capacitance codeCode107Capacitance (μF)100
.2	Rated voltage code
	Part number1VRate Voltage (V.DC)35
.3	TypeCodeCBReferenceBulk
.4	<u>Capacitance tolerance</u> "M" stands for $-20\% \sim +20\%$
.5.	Size Code E Diameter 6.3
.6	Length "11" stands for 11mm
.7	Sleeve material Code P
	Sleeve materialPETRemark: The "** " in fifteenth and sixteenth digits is used for the product lines.

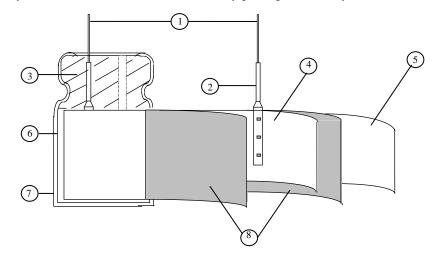
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3. Construction

Single ended type to be produced to fix the terminals to anode and cathode foil, and wind together with paper, and then wound element to be impregnated with electrolyte will be enclosed in an aluminum case. Finally sealed up tightly with end seal rubber, then finished by putting on the vinyl sleeve.



	Component	Material
1	Lead line	Tinned CP wire (Pb Free)
2	Terminal	Aluminum wire
3	Sealing Material	Rubber
4	Al-Foil (+)	Formed aluminum foil
5	Al-Foil (-)	Etched aluminum foil or formed aluminum foil
6	Case	Aluminum case
7	Sleeve	PET
8	Separator	Electrolyte paper

4. Characteristics

Standard atmospheric conditions

Unless otherwise specified, the standard range of atmospheric conditions for making measurements and tests are as follows:

Ambient temperature	:15°C to 35°C
Relative humidity	: 45% to 85%
Air Pressure	: 86kPa to 106kPa

If there is any doubt about the results, measurement shall be made within the following conditions:

Ambient temperature	$: 20^{\circ}C \pm 2^{\circ}C$
Relative humidity	: 60% to 70%
Air Pressure	: 86kPa to 106kPa

Operating temperature range

The ambient temperature range at which the capacitor can be operated continuously at rated voltage See table 1 temperature range.

As to the detailed information, please refer to table 2.

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Tabl	e 2									
	ITEM				PERFO	RMANC	СЕ			
	Rated voltage (WV)									
4.1		WV (V.DC)	6.3	10	16	25	35	50	63	100
	Surge voltage (SV)	SV (V.DC)	8	13	20	32	44	63	79	125
4.2	Nominal capacitance (Tolerance)	<condition> Measuring F Measuring V Measuring T <criteria> Shall be with</criteria></condition>	requenc oltage 'emperat	: N ure : 20	20 Hz \pm 12 fot more t $0 \pm 2^{\circ}$ apacitanc	han 0.5V				
4.3	Leakage current	<pre><condition> Connecting the capacitor with a protective resistor $(1k\Omega \pm 10\Omega)$ in series for 2 minutes, and then, measure Leakage Current. </condition></pre> Refer to Table 1								
4.4	tanδ	<condition> See 4.2, Norm Capacitance, for measuring frequency, voltage and temperature.<criteria> Refer to Table 1</criteria></condition>								
4.5	Terminal strength	Refer to Table 1 < Condition> Tensile Strength of TerminalsFixed the capacitor, applied force to the terminal (1~4 mm from the rubber) for 90° within 2~3 seconds, and then bent it for 90° to its original position within 2~3 seconds.Diameter of lead wireTensile force NBending force N0.5mm and less5 (0.51)2.5 (0.25)0ver 0.5mm to 0.8mm10 (1.0)5 (0.51)Criteria>No noticeable changes shall be found, no breakage or looseness at the terminal.								

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		S		U	erature(°C)		. 1	Time	.1.1 .	
			1	20 ± 2			Time to reach thermal equilibri			
			2	-40(-25)			to reach		-	
			3	20±2			to reach			
			4	$105 \pm$			to reach		•	
			5 20 ± 2 Time to reach thermal equili					equilibri	um	
		<criteri< td=""><td></td><td>• 4 1•</td><td></td><td>4 4751 1</td><td>1</td><td></td><td>1</td><td>1 11 /</td></criteri<>		• 4 1•		4 4751 1	1		1	1 11 /
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	characteristi		an the specific				11 4.41110	leakage	current	shan not
4.6	cs)℃ (-25℃), i		(z) ratio	shall not	exceed th	e value o	of the fol	llowing
		table.	, , , , , , , , , , , , , , , , , , , ,	mpedanee	(2) 1410	sinuir not	enecce u	ie varae v		ilo wing
			Voltage (V)	6.3	10	16	25	35	50	63
			C/Z+20°C	4	3	2	2	2	2	2
		Z-40°C	C/Z+20℃	8	6	4	3	3	3	3
		***		100	1					
			Voltage (V)	100	-					
			C/Z+20°C	2	-					
			C/Z+20°C	3		~	1 100			2000
		For capa	citance value	> 1000µ		5 per and	ther 1000	Jµ F for	L-23/L+	-20 C,
					A J J 1 (1 1000	L. Efend	7 1000	7.0000
		Canacitan	nca tanδ an	d impada) per ano			Z-40°C/Z	Z+20℃.
		Capacitan	nce, tan δ , an	d impedai		-			Z-40℃/2	Z+20℃.
		<condit< td=""><td>ion></td><td>-</td><td>nce shall b</td><td>e measur</td><td>red at 120</td><td>)Hz.</td><td></td><td></td></condit<>	ion>	-	nce shall b	e measur	red at 120)Hz.		
		<condit Accordin</condit 	ion> ng to IEC603	34-4No.4.	nce shall b	e measur	red at 120	Hz.	at a temp	erature of
		<condit< b=""> Accordir 105 ℃ ±</condit<>	ion> ng to IEC6033 2 with DC bi	34-4No.4. ias voltage	nce shall b 13 method e plus the p	ds, The ca	red at 120 apacitor is le curren	bHz. s stored a t for Tab	nt a temp ble 1. (T	erature of
		<condit Accordir 105 ℃ ± DC and</condit 	ion> ng to IEC603 2 with DC bi ripple peak	34-4No.4. ias voltage voltage sl	13 method plus the main and the second secon	ds, The ca rated ripp	pacitor is le curren e rated w	s stored a t for Tab	nt a temp ble 1. (T voltage)	erature of he sum of Then the
		Condit Accordir $105 \ C \pm$ DC and product s	ion> ng to IEC603 2 with DC bi ripple peak should be test	84-4No.4. ias voltage voltage sl ed after 10	13 method e plus the hall not e 6 hours red	ds, The ca rated ripp	pacitor is le curren e rated w	s stored a t for Tab	nt a temp ble 1. (T voltage)	erature of he sum of Then the
47	Load	<condit< th="">Accordir$105 \ C \pm$DC andproduct sresult sho</condit<>	ion> ng to IEC6033 2 with DC bi ripple peak should be test ould meet the	84-4No.4. ias voltage voltage sl ed after 10	13 method e plus the hall not e 6 hours red	ds, The ca rated ripp	pacitor is le curren e rated w	s stored a t for Tab	nt a temp ble 1. (T voltage)	erature of he sum of Then the
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4.7		Condit Accordir 105 ℃ ± DC and product s result sho <criteri The char</criteri 	ion> ng to IEC6033 2 with DC bi ripple peak should be test ould meet the ia>	84-4No.4. ias voltage voltage sl ed after 10 following ill meet th	13 method e plus the r hall not e 5 hours red g table: e followir	ds, The ca rated ripp xceed the	ed at 120 apacitor is le curren e rated w time at at	oHz. s stored a t for Tab orking v mospher	nt a temp ble 1. (T voltage)	erature of he sum of Then the
4.7	life	<condit< th="">Accordir$105 \ C \pm$DC andproduct sresult shot<criteri< td="">The charLate</criteri<></condit<>	ion> ig to IEC6033 2 with DC bin ripple peak should be test ould meet the ia> racteristic sha	84-4No.4. ias voltage sl ed after 16 following ill meet th nt	13 method e plus the p hall not e. 6 hours red g table: e followir Value in	ds, The ca rated ripp xceed the covering	ed at 120 apacitor is le curren e rated w time at at ements. be satisf	oHz. s stored a t for Tab yorking v mospher	nt a temp ble 1. (T voltage)	erature of he sum of Then the
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	<criteria></criteria>	
	The characteristic shall meet	the following requirements.
	Leakage current	Value in 4.3 shall be satisfied
Shelf	Capacitance Change	Within $\pm 25\%$ of initial value.
4.8 life	tanδ	Not more than 150% of the specified value.
test	Appearance	There shall be no leakage of electrolyte.
		stored more than 1 year, the leakage current may
	-	e through about 1 k Ω resistor, if necessary.
	The capacitor shall be submit followed discharge of 5 min The test temperature shall b	be 15~35°C.
	C_{R} :Nominal Capacitance (JF)
4 O Surge	<criteria></criteria>	
4.9 test	Leakage current	Not more than the specified value.
	Capacitance Change	Within $\pm 15\%$ of initial value.
	tanδ	Not more than the specified value.
	Appearance	There shall be no leakage of electrolyte.
	This test simulates over volta over voltage as often applied <condition></condition>	ge at abnormal situation only. It is not applicable to such
4.10 Vibration test	perpendicular directions. Vibration frequency rate Peak to peak amplitude Sweep rate Mounting method: The capacitor with diameter ge in place with a bracket. 4mm or less ✓	e : 1.5mm : 10Hz ~ 55Hz ~ 10Hz in about 1 minute greater than 12.5mm or longer than 25mm must be fixed Within 30°

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		<condition></condition>					
		The capacitor shall be test	ted und		conditions:		
		Soldering temperature					
	0 11 111	Dipping depth		: 2mm			
4.11 Solderability	Dipping speed		: 25±2.5mm/s				
	test	Dipping time <criteria></criteria>		: 3±0.5s			
		<criteria></criteria>		A minimum	n of 95% of the surface	haing	
		Coating quality		immersed	101 75 % of the surface	being	
		<condition></condition>					
		Terminals of the capacitor					
		1 seconds or $400 \pm 10^{\circ}$ C fo	$r3^{+1}_{-0}se$	econds to 1.5~2.0	mm from the body of c	capacitor .	
		Then the capacitor shall b	e left u	under the normal t	emperature and norma	l humidity	
	Resistance to	for 1~2 hours before meas	sureme	ent.	-		
4.12	solder heat	<criteria></criteria>					
	test	Leakage current		Not more than the	ne specified value.		
		Capacitance Change		Within $\pm 10\%$ o	of initial value.		
		tanδ		Not more than the	he specified value.		
		Appearance		There shall be no	o leakage of electrolyt	e.	
		<condition></condition>					
		Temperature Cycle:Accor	•		-	shall be	
		placed in an oven, the condition according as below: Temperature Time					
			ture	Time			
		(1)+20℃		≤ 3 Minute			
	Change of	(2)Rated low tempera	ature (-	40°C)(-25°C)	30 ± 2 Minutes		
4.13	temperature	(3)Rated high temper	ature (+105°C)	30 ± 2 Minutes		
	test	(1) to (3)=1 cycle, tot	tal 5 cy	vcle			
		<criteria></criteria>					
		The characteristic shall m	eet the	following require	ement	_	
		Leakage current	No	Not more than the specified value.			
		tanδ	No	Not more than the specified value.			
		Appearance	Th	ere shall be no le	akage of electrolyte.		
		<condition></condition>					
		Humidity Test:					
		According to IEC60384-4		-	-		
		hours in an atmosphere of			C, the characteristic cl	hange shall	
		meet the following require	ement.				
		< <u>Criteria></u>	Notn	nore then the energy	ified value		
4.14	Damp heat	Leakage current		nore than the spectrum $\pm 20\%$ of initi			
	test	Capacitance Change tanδ			f the specified value.		
					age of electrolyte.		
		Appearance	There	Shan be no redka	ige of electrolyte.		

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ELECTROLYTIC CAPACITOR SPECIFICATION GF SERIES



4.15	Vent test	22.4 or less	ith its po	larity re plied.		-		
		The vent shall operate with no pieces of the capacitor and/or	case.				-	n of
		The maximum permissible r at 100kHz and can be appli Table-1 The combined value of D.C rated voltage and shall not Frequency Multipliers:	ed at max	timum of and the j	perating	temperat	ture	1 the
		Coefficient Freq. (Hz) Cap. (µ F)	120		1k	10k	100k	
	Maximum permissible	~180	0.40	0	.75	0.90	1.00	
4.16	(ripple	220~560	0.50		.85	0.94	1.00	
	current)	680~1800	0.60	0	.87	0.95	1.00	
	,	2200~3900	0.75		.90	0.95	1.00	
		4700	0.85	0	.95	0.98	1.00	
		Temperature Coefficie	ent:					
		Temperature ($^{\circ}$ C)	85	95	105			
		Factor	1.73	1.41	1.00			

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5. It refers to the latest document of "Environment-related Substances standard" (WI-HSPM-QA-072).

	Substances
	Cadmium and cadmium compounds
Heavy metals	Lead and lead compounds
Treavy metals	Mercury and mercury compounds
	Hexavalent chromium compounds
	Polychlorinated biphenyls (PCB)
Chloinated	Polychlorinated naphthalenes (PCN)
organic	Polychlorinated terphenyls (PCT)
compounds	Short-chain chlorinated paraffins(SCCP)
	Other chlorinated organic compounds
D	Polybrominated biphenyls (PBB)
Brominated .	Polybrominated diphenylethers(PBDE) (including
organic	decabromodiphenyl ether[DecaBDE])
compounds	Other brominated organic compounds
Tributyltin comp	oounds(TBT)
Triphenyltin con	npounds(TPT)
Asbestos	
Specific azo com	pounds
Formaldehyde	
Beryllium oxide	
Beryllium copp	er
Specific phthalat	es (DEHP,DBP,BBP,DINP,DIDP,DNOP,DNHP)
Hydrofluorocarb	on (HFC), Perfluorocarbon (PFC)
Perfluorooctane	sulfonates (PFOS)
Specific Benzotr	iazole

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SAMXON

Attachment: Application Guidelines

1.Circuit Design

- 1.1 Operating Temperature and Frequency Electrolytic capacitor electrical parameters are normally specified at 20°C temperature and 120Hz frequency. These parameters vary with changes in temperature and frequency. Circuit designers should take these changes into consideration.
- (1) Effects of operating temperature on electrical parameters
 a) At higher temperatures, leakage current and capacitance increase while equivalent series resistance (ESR) decreases.
 - b) At lower temperatures, leakage current and capacitance decrease while equivalent series resistance (ESR) decreases.
- (2) Effects of frequency on electrical parameters
 - a) At higher frequencies capacitance and impedance decrease while $\tan \delta$ increases.
 - b) At lower frequencies, ripple current generated heat will rise due to an increase in equivalent series resistance (ESR).
- 1.2 Operating Temperature and Life Expectancy See the file: Life calculation of aluminum electrolytic capacitor
- 1.3 Common Application Conditions to Avoid

The following misapplication load conditions will cause rapid deterioration to capacitor electrical parameters. In addition, rapid heating and gas generation within the capacitor can occur causing the pressure relief vent to operate and resultant leakage of electrolyte. Under Leaking electrolyte is combustible and electrically conductive.

(1) Reverse Voltage

DC capacitors have polarity. Verify correct polarity before insertion. For circuits with changing or uncertain polarity, use DC bipolar capacitors. DC bipolar capacitors are not suitable for use in AC circuits.

(2) Charge / Discharge Applications

Standard capacitors are not suitable for use in repeating charge / discharge applications. For charge / discharge applications consult us and advise actual conditions.

(3) Over voltage

Do not apply voltages exceeding the maximum specified rated voltage. Voltages up to the surge voltage rating are acceptable for short periods of time. Ensure that the sum of the DC voltage and the superimposed AC ripple voltage does not exceed the rated voltage.

(4) Ripple Current

Do not apply ripple currents exceeding the maximum specified value. For high ripple current applications, use a capacitor designed for high ripple currents or contact us with your requirements. Ensure that allowable ripple currents superimposed on low DC bias voltages do not cause reverse voltage conditions.

- 1.4 Using Two or More Capacitors in Series or Parallel
- (1) Capacitors Connected in Parallel

The circuit resistance can closely approximate the series resistance of the capacitor causing an imbalance of ripple current loads within the capacitors. Careful design of wiring methods can minimize the possibility of excessive ripple currents applied to a capacitor.

(2) Capacitors Connected in Series

Normal DC leakage current differences among capacitors can cause voltage imbalances. The use of voltage divider shunt resistors with consideration to leakage current can prevent capacitor voltage imbalances.

- 1.5 Capacitor Mounting Considerations
- (1) Double Sided Circuit Boards

Avoid wiring pattern runs, which pass between the mounted capacitor and the circuit board.

When dipping into a solder bath, excess solder may collect under the capacitor by capillary action and short circuit the anode and cathode terminals.

(2)Circuit Board Hole Positioning

The vinyl sleeve of the capacitor can be damaged if solder passes through a lead hole for subsequently processed parts. Special care when locating hole positions in proximity to capacitors is recommended.

(3)Circuit Board Hole Spacing

The circuit board holes spacing should match the capacitor lead wire spacing within the specified tolerances. Incorrect spacing can cause excessive lead wire stress during the insertion process. This may result in premature capacitor failure due to short or open circuit, increased leakage current, or electrolyte leakage.

(4) Clearance for Case Mounted Pressure Relief vents

Capacitors with case mounted pressure relief vents require sufficient clearance to allow for proper vent operation. The minimum clearances are dependent on capacitor diameters as proper vent operation. The minimum clearances are dependent on capacitor diameters as follows.

φ6.3~φ16mm:2mm minimum, φ18~φ35mm:3mm minimum, φ40mm or greater:5mm minimum.

(5) Clearance for Seal Mounted Pressure Relief Vents

A hole in the circuit board directly under the seal vent location is required to allow proper release of pressure.

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GT SERIES
 (6) Wiring Near the Pressure Relief Vent Avoid locating high voltage or high current wiring or circuit board paths above the pressure relief vent. Flammable, high temperature gas exceeding 100°C may be released which could dissolve the wire insulation and ignite. (7) Circuit Board patterns Under the Capacitor Avoid circuit board runs under the capacitor as electrolyte leakage could cause an electrical short. (8) Screw Terminal Capacitor Mounting Do not orient the capacitor with the screw terminal side of the capacitor facing downwards. Tighten the terminal and mounting bracket screws within the torque range specified in the specification.
 Electrical Isolation of the Capacitor Completely isolate the capacitor as follows. Between the cathode and the case (except for axially leaded B types) and between the anode terminal and other circuit paths Between the extra mounting terminals (on T types) and the anode terminal, cathode terminal, and other circuit paths.
1.7 The Product endurance should take the sample as the standard.
1.8 If conduct the load or shelf life test, must be collect date code within 6 months products of sampling.
 Capacitor Sleeve The vinyl sleeve or laminate coating is intended for marking and identification purposes and is not meant to electrically insulate the capacitor. The sleeve may split or crack if immersed into solvents such as toluene or xylene, and then exposed to high temperatures.
CAUTION!
 Always consider safety when designing equipment and circuits. Plan for worst case failure modes such as short circuits and open circuits which could occur during use. (1) Provide protection circuits and protection devices to allow safe failure modes. (2) Design redundant or secondary circuits where possible to assure continued operation in case of main circuit failure.
2.Capacitor Handling Techniques
 Considerations Before Using Capacitors have a finite life. Do not reuse or recycle capacitors from used equipment. Transient recovery voltage may be generated in the capacitor due to dielectric absorption. If required, this voltage can be discharged with a resistor with a value of about 1kΩ. Capacitors stored for long periods of time may exhibit an increase in leakage current. This can be corrected by gradually applying rated voltage in series with a resistor of approximately 1kΩ. If capacitors are dropped, they can be damaged mechanically or electrically. Avoid using dropped capacitors. Dented or crushed capacitors should not be used. The seal integrity can be compromised and loss of electrolyte / shortened life can result.
 2.2 Capacitor Insertion (1) Verify the correct capacitance and rated voltage of the capacitor. (2) Verify the correct polarity of the capacitor before inserting. (3) Verify the correct hole spacing before insertion (land pattern size on chip type) to avoid stress on the terminals. (4) Ensure that the auto insertion equipment lead clinching operation does not stress the capacitor leads where they enter the seal of the capacitor. For chip type capacitors, excessive mounting pressure can cause high leakage current, short circuit, or disconnection.
 2.3 Manual Soldering (1) Observe temperature and time soldering specifications or do not exceed temperatures of 400 °C for 3 seconds or less. (2) If lead wires must be formed to meet terminal board hole spacing, avoid stress on the lead wire where it enters the capacitor seal. (3) If a soldered capacitor must be removed and reinserted, avoid excessive stress to the capacitor leads. (4) Avoid touching the tip of the soldering iron to the capacitor, to prevent melting of the vinyl sleeve.

- 2.4 Flow Soldering
- (1) Do not immerse the capacitor body into the solder bath as excessive internal pressure could result.
- (2) Observe proper soldering conditions (temperature, time, etc.) Do not exceed the specified limits.
- (3) Do not allow other parts or components to touch the capacitor during soldering.
- 2.5 Other Soldering Considerations

Rapid temperature rises during the preheat operation and resin bonding operation can cause cracking of the capacitor vinyl sleeve. For heat curing, do not exceed 150°C for a maximum time of 2 minutes.

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2.6 Capacitor Handling after Solder

- (1). Avoid movement of the capacitor after soldering to prevent excessive stress on the lead wires where they enter the seal.
- (2). Do not use capacitor as a handle when moving the circuit board assembly.
- (3). Avoid striking the capacitor after assembly to prevent failure due to excessive shock.
- 2.7 Circuit Board Cleaning

Acetone

- (1) Circuit boards can be immersed or ultrasonically cleaned using suitable cleaning solvents for up 5 minutes and up to 60°C maximum temperatures. The boards should be thoroughly rinsed and dried. The use of ozone depleting cleaning agents is not recommended in the interest of protecting the environment.
- (2) Avoid using the following solvent groups unless specifically allowed for in the specification;

Halogenated cleaning solvents: except for solvent resistant capacitor types, halogenated solvents can permeate the seal and cause internal capacitor corrosion and failure. For solvent resistant capacitors, carefully follow the temperature and time requirements of the specification. 1-1-1 trichloroethane should never be used on any aluminum electrolytic capacitor.

- Alkali solvents : could attack and dissolve the aluminum case.
- Petroleum based solvents: deterioration of the rubber seal could result.
- Xylene : deterioration of the rubber seal could result.
 - : removal of the ink markings on the vinyl sleeve could result.
- (3) A thorough drying after cleaning is required to remove residual cleaning solvents which may be trapped between the capacitor and the circuit board. Avoid drying temperatures, which exceed the maximum rated temperature of the capacitor.
- (4) Monitor the contamination levels of the cleaning solvents during use by electrical conductivity, pH, specific gravity, or water content. Chlorine levels can rise with contamination and adversely affect the performance of the capacitor. Please consult us for additional information about acceptable cleaning solvents or cleaning methods.

2.8 Mounting Adhesives and Coating Agents

When using mounting adhesives or coating agents to control humidity, avoid using materials containing halogenated solvents. Also, avoid the use of chloroprene based polymers. After applying adhesives or coatings, dry thoroughly to prevent residual solvents from being trapped between the capacitor and the circuit board.

3. Precautions for using capacitors

3.1 Environmental Conditions

- Capacitors should not be stored or used in the following environments.
- (1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.
- (2) Direct contact with water, salt water, or oil.
- (3) High humidity conditions where water could condense on the capacitor.
- (4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid chlorine, or ammonia.
- (5) Exposure to ozone, radiation, or ultraviolet rays.
- (6) Vibration and shock conditions exceeding specified requirements.

3.2 Electrical Precautions

- (1) Avoid touching the terminals of the capacitor as possible electric shock could result. The exposed aluminum case is not insulated and could also cause electric shock if touched.
- (2) Avoid short circuit the area between the capacitor terminals with conductive materials including liquids such as acids or alkaline solutions.

4. Emergency Procedures

- (1) If the pressure relief vent of the capacitor operates, immediately turn off the equipment and disconnect form the power source. This will minimize additional damage caused by the vaporizing electrolyte.
- (2) Avoid contact with the escaping electrolyte gas which can exceed 100°C temperatures.

If electrolyte or gas enters the eye, immediately flush the eyes with large amounts of water.

If electrolyte or gas is ingested by month, gargle with water.

If electrolyte contacts the skin, wash with soap and water.

5. Long Term Storage

Leakage current of a capacitor increases with long storage times. The aluminum oxide film deteriorates as a function of temperature and time. If used without reconditioning, an abnormally high current will be required to restore the oxide film. This current surge could cause the circuit or the capacitor to fail. After one year, a capacitor should be reconditioned by applying rated voltage in series with a 1000Ω , current limiting resistor for a time period of 30 minutes. If the expired date of products date code is over eighteen months, the products should be return to confirmation.

5.1 Environmental Conditions

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The capacitor shall be not use in the following condition:

(1) Temperature exposure above the maximum rated or below the minimum rated temperature of the capacitor.

(2) Direct contact with water, salt water, or oil.

(3) High humidity conditions where water could condense on the capacitor.

(4) Exposure to toxic gases such as hydrogen sulfide, sulfuric acid, nitric acid, chlorine, or ammonia.

(5) Exposure to ozone, radiation, or ultraviolet rays.

(6) Vibration and shock conditions exceeding specified requirements.

6. Capacitor Disposal

When disposing of capacitors, use one of the following methods.

Incinerate after crushing the capacitor or puncturing the can wall (to prevent explosion due to internal pressure rise). Capacitors should be incinerated at high temperatures to prevent the release of toxic gases such as chlorine from the

polyvinyl chloride sleeve, etc.

Dispose of as solid waste.

NOTE: Local laws may have specific disposal requirements, which must be followed.

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